


<b>Search Notes</b>  	<b>Application/Control No.</b>  10083707	<b>Applicant(s)/Patent Under Reexamination</b>  BRUCKER ET AL.
	<b>Examiner</b>  Ho, (Jackie) Tan-Uyen T	<b>Art Unit</b>  3731

SEARCHED			
Class	Subclass	Date	Examiner
606	200	2/15/07	JH
623	1.11, 1.35, 1.15	2/15/07	JH
606	194, 108	9/23/07	Jh
623	1.11, 1.35, 1.15	9/23/07	JH

SEARCH NOTES		
Search Notes	Date	Examiner
See text search attached	9/23/07	JH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner